

Notice of References Cited	Application/Control No. 10/573,816		Applicant(s)/Patent Under Reexamination YOSHIKAWA ET AL.	
	Examiner KHANH C. TRAN		Art Unit 2611	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0151257	08-2004	Staszewski et al.	375/296
*	B	US-6,567,478	05-2003	Oishi et al.	375/297
*	C	US-2002/0071497	06-2002	Bengtsson et al.	375/298
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.